

AO3406

N-Channel Enhancement Mode Field Effect Transistor

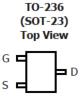


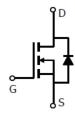
General Description

The AO3406 uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$ and low gate charge. This device is suitable for use as a load switch or in PWM applications. Standard Product AO3406 is Pb-free (meets ROHS & Sony 259 specifications). AO3406L is a Green Product ordering option. AO3406 and AO3406L are electrically identical.

Features

$$\begin{split} &V_{DS}\left(V\right) = 30V \\ &I_{D} = 3.6A \; \left(V_{GS} = 10V\right) \\ &R_{DS(ON)} < 65 m\Omega \; (V_{GS} = 10V) \\ &R_{DS(ON)} < 105 m\Omega \; (V_{GS} = 4.5V) \end{split}$$





Absolute Maximum Ratings T _A =25°C unless otherwise noted								
Parameter		Symbol	Maximum	Units				
Drain-Source Voltage		V_{DS}	30	V				
Gate-Source Voltage		V_{GS}	±20	V				
Continuous Drain	T _A =25°C		3.6					
Current ^A	T _A =70°C	I_D	2.9	Α				
Pulsed Drain Current ^B		I _{DM}	15					
	T _A =25°C	В	1.4	10/				
Power Dissipation ^A	T _A =70°C	P_{D}	0.9	W				
Junction and Storage Temperature Range		T_J , T_{STG}	-55 to 150	°C				

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	70	90	°C/W			
Maximum Junction-to-Ambient A	Steady-State	state N _{eJA}		125	°C/W			
Maximum Junction-to-Lead ^C	Steady-State	$R_{\theta JL}$	63	80	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV _{DSS}	Drain-Source Breakdown Voltage	I_D =250μA, V_{GS} =0V	30			V				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V			1	μА				
		T _J =55°C			5					
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V			100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$	1	1.9	3	V				
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V	15			Α				
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =3.6A		50	65	mΩ				
		T _J =125°C		74	100	11122				
		V_{GS} =4.5V, I_{D} =2.8A		75	105	mΩ				
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =3.6A		7		S				
V_{SD}	Diode Forward Voltage	I _S =1A		0.79	1	V				
I_S	Maximum Body-Diode Continuous Current				2.5	Α				
DYNAMIC	PARAMETERS	•		-						
C _{iss}	Input Capacitance			288	375	pF				
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =15V, f=1MHz		57		pF				
C_{rss}	Reverse Transfer Capacitance			39		pF				
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		3	6	Ω				
SWITCHII	NG PARAMETERS									
Q _g (10V)	Total Gate Charge			6.5	8.5	nC				
$Q_g(4.5V)$	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =3.6A		3.1	4	nC				
Q_{gs}	Gate Source Charge	VGS=10V, VDS=10V, ID=0.0/		1.2		nC				
Q_{gd}	Gate Drain Charge			1.6		nC				
t _{D(on)}	Turn-On DelayTime			4.6		ns				
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =2.2 Ω ,		1.9		ns				
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		20.1		ns				
t _f	Turn-Off Fall Time			2.6		ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =3.6A, dI/dt=100A/μs		10.2	14	ns				
Q_{rr}	Body Diode Reverse Recovery Charge I _F =3.6A, dI/dt=100A/μs			3.5		nC				

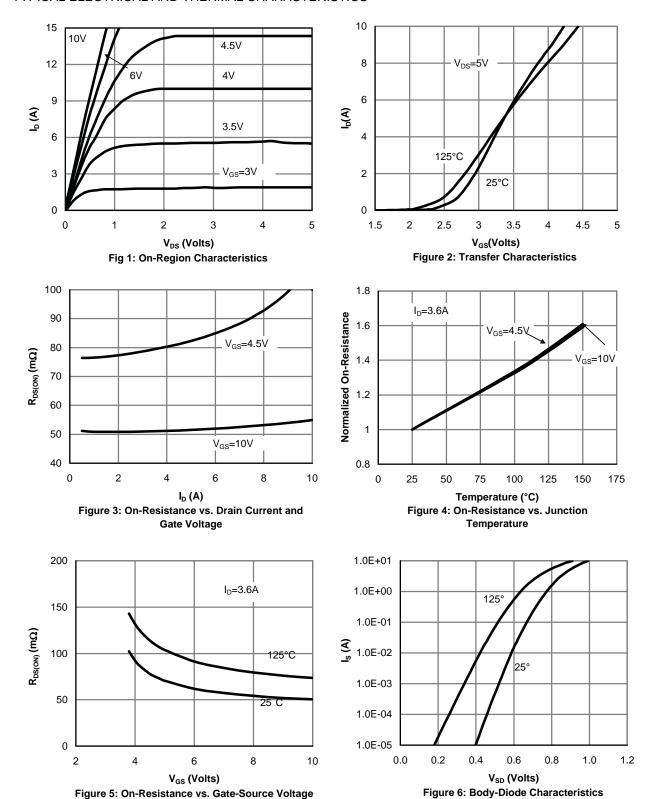
A: The value of $R_{\theta JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t≤ 10s thermal resistance rating.

- B: Repetitive rating, pulse width limited by junction temperature.
- C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.
- D. The static characteristics in Figures 1 to 6,12,14 are obtained using $80\,\mu s$ pulses, duty cycle 0.5% max.
- E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The SOA curve provides a single pulse rating.

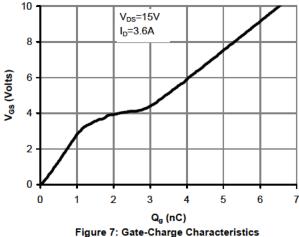
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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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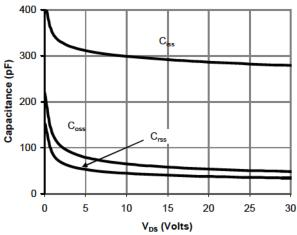


Figure 8: Capacitance Characteristics

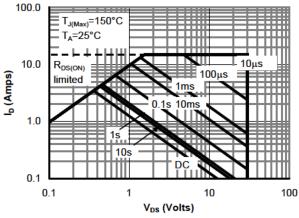


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

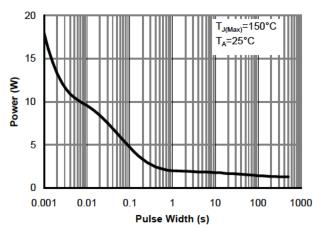


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

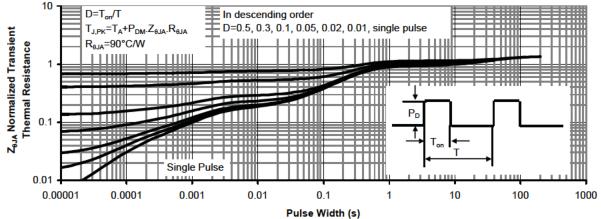


Figure 11: Normalized Maximum Transient Thermal Impedance